Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination TAKE, KEIJIRO	
10/796,094		
Examiner	Art Unit	
Tri H. Phan	2661	

SEARCHED					
Class	Subclass	Date	Examiner		
370	320,335, 342,441, 479,203	12/3/2004	TP		
370	350,332	12/3/2004	TP		
370	508-510	12/3/2004	TP		
375	200	12/3/2004	TP		
Updated	search	6/20/2005	TP		
Updated	search	2/6/2006	TP		
		, <u>, , </u>			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST, IEEE, Internet searched	12/3/2004	TP
Inventorship search	6/20/2005	ΤP
Consulted with Brian Nguyen (Pri)	1/19/2006	TP